

Search Notes

Application/Control No.

10/715,222

Examiner

Erin M. File

Applicant(s)/Patent under
Reexamination

MARTIN ET AL.

Art Unit

2611

SEARCHED

Class	Subclass	Date	Examiner
375	238	10/5/2006	EMF
375	239	10/5/2006	EMF
375	242	10/5/2006	EMF
375	256	10/5/2006	EMF
375	257	10/5/2006	EMF
375	286	10/5/2006	EMF
375	353	10/5/2006	EMF
307	200.1	10/5/2006	EMF
329	300	10/5/2006	EMF
329	304	10/5/2006	EMF
341	126	10/5/2006	EMF
455	130	10/5/2006	EMF
455	296	10/5/2006	EMF

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM (text search only— see search history printout)	10/5/2006	EMF
PLUS Search	8/14/2006	EMF